## Low voltage CMOS 16-bit bus buffer (3-state non inverter)

 with 3.6 V tolerant inputs and outputs
## Features

■ 1.65 to 3.6 V inputs and outputs
■ High speed:
$-\mathrm{t}_{\mathrm{PD}}=3.4 \mathrm{~ns}$ at $\mathrm{V}_{\mathrm{CC}}=3.0$ to 3.6 V
$-\mathrm{t}_{\mathrm{PD}}=3.8 \mathrm{~ns}$ at $\mathrm{V}_{\mathrm{CC}}=2.3$ to 2.7 V

- Power down protection on inputs and outputs
- Symmetrical output impedance:
- $\|_{\mathrm{OH}}{ }^{I}=\mathrm{I}_{\mathrm{OL}}=12 \mathrm{~mA}$ (Min.) at $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}$
- $\|_{\mathrm{OH}} \mathrm{I}=\mathrm{I}_{\mathrm{OL}}=8 \mathrm{~mA}$ (Min.) at $\mathrm{V}_{\mathrm{CC}}=2.3 \mathrm{~V}$
- $26 \Omega$ serie resistors in outputs
- Operating voltage range:
- $\mathrm{V}_{\mathrm{CC}}(\mathrm{Opr})=1.65 \mathrm{~V}$ to 3.6 V
- Pin and function compatible with 54 series H162244
- Bus hold provided on data inputs
- Cold spare function
- Latch-up performance exceeds 300 mA (JESD 17)
- ESD performance:
- HBM > 2000 V
(Mil Std 883 Method 3015); MM > 200 V
■ 300 krad Mil1019.6 condition A, (RHA QML qualification extension undergone)
- No SEL, no SEU and no SET under 110 $\mathrm{Mev} / \mathrm{cm} 2 / \mathrm{mg}$ LET heavy ions irradiation
- QML qualified product
- SMD 5962-05210
- 100 mV typical input hysteresis


Flat-48
The upper metallic lid is not electrically connected to any pins, nor to the IC die inside the package.

## Description

The 54VCXH162244 is a low voltage CMOS 16 bit bus buffer (non inverted) fabricated with submicron silicon gate and five-layer metal wiring $\mathrm{C}^{2}$ MOS technology. It is ideal for low power and very high speed 1.65 to 3.6 V applications; it can be interfaced to 3.6 V signal environment for both inputs and outputs. Any n $\bar{G}$ output control governs four BUS buffers. Output enable input ( $\mathrm{n} \overline{\mathrm{G}}$ ) tied together gives full 16-bit operation. When $n \bar{G}$ is low, the outputs are on. When $n \bar{G}$ is high, the output are in high impedance state. This device is designed to be used with 3 state memory address drivers, etc. Bus hold on data inputs is provided in order to eliminate the need for external pull-up or pull-down resistor. The device circuits is including $26 \Omega$ series resistance in the outputs. These resistors permit to reduce line noise in high speed applications. All inputs and outputs are equipped with protection circuits against static discharge, giving them 2 kV ESD immunity and transient excess voltage.

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Logic symbols and I/O equivalent circuit

Figure 1. IEC logic symbols


Figure 2. Input and output equivalent circuit


## 2 Pin settings

### 2.1 Pin connection

Figure 3. Pin connection (top through view)


### 2.2 Pin description

Table 1. Pin description

| ${\text { Pin } n^{\circ}}^{\circ}$ | Symbol | Name and function |
| :---: | :---: | :--- |
| 1 | $1 \overline{\mathrm{G}}$ | Output enable input |
| $2,3,5,6$ | 1 Y 1 to 1 Y 4 | Data outputs |
| $8,9,11,12$ | 2 Y 1 to 2 Y 4 | Data outputs |
| $13,14,16,17$ | 3 Y 1 to 3 Y 4 | Data outputs |
| $19,20,22,23$ | 4 Y 1 to 4 Y 4 | Data outputs |
| 24 | $4 \overline{\mathrm{G}}$ | Output enable input |
| 25 | $3 \overline{\mathrm{G}}$ | Output enable input |
| $30,29,27,26$ | 4 A 1 to 4 A 4 | Data outputs |
| $36,35,33,32$ | 3 A 1 to 3 A 4 | Data outputs |
| $41,40,38,37$ | 2 A 1 to 2 A 4 | Data outputs |
| $47,46,44,43$ | 1 A 1 to 1 A 4 | Data outputs |
| 48 | $2 \overline{\mathrm{G}}$ | Output enable Input |
| $4,10,15,21,28,34,39,45$ | GND | Ground (0 V) |
| $7,18,31,42$ | $\mathrm{~V}_{\mathrm{CC}}$ | Positive supply voltage |

### 2.3 Truth table

Table 2. Truth table

| Inputs |  | Output |
| :---: | :---: | :---: |
| G | An | Yn |
| L | L | L |
| L | H | H |
| H | X | Z |

Note: $\quad X=$ Do not care $; Z=$ High impedance

## 3 Maximum rating

Stressing the device above the rating listed in the "absolute maximum ratings" table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Table 3. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
| :---: | :--- | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | Supply voltage | -0.5 to +4.6 | V |
| $\mathrm{~V}_{\mathrm{I}}$ | DC input voltage | -0.5 to +4.6 | V |
| $\mathrm{~V}_{\mathrm{O}}$ | DC output voltage (OFF state) | -0.5 to +4.6 | V |
| $\mathrm{~V}_{\mathrm{O}}$ | DC output voltage (high or low state) ${ }^{(1)}$ | -0.5 to $\mathrm{V}_{\mathrm{CC}}+0.5$ | V |
| $\mathrm{I}_{\mathrm{I}}$ | DC input diode current | -50 | mA |
| $\mathrm{I}_{\mathrm{OK}}$ | DC output diode current ${ }^{(2)}$ | -50 | mA |
| $\mathrm{I}_{\mathrm{O}}$ | DC output current | $\pm 50$ | mA |
| $\mathrm{I}_{\mathrm{CC}}$ or |  |  |  |
| $\mathrm{I}_{\mathrm{GND}}$ | DC $\mathrm{V}_{\mathrm{CC}}$ or ground current per supply pin | $\pm 100$ | mA |
| $\mathrm{P}_{\mathrm{D}}$ | Power dissipation | 400 | mW |
| $\mathrm{~T}_{\text {stg }}$ | Storage temperature | -65 to +150 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\mathrm{L}}$ | Lead temperature (10 sec) | 260 | ${ }^{\circ} \mathrm{C}$ |

1. $\mathrm{I}_{\mathrm{O}}$ absolute maximum rating must be observed
2. $\mathrm{V}_{\mathrm{O}}<\mathrm{GND}, \mathrm{V}_{\mathrm{O}}>\mathrm{V}_{\mathrm{CC}}$

### 3.1 Recommended operating conditions

Table 4. Recommended operating conditions

| Symbol | Parameter | Value | Unit |
| :---: | :--- | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | Supply voltage | 1.8 to 3.6 | V |
| $\mathrm{~V}_{\mathrm{I}}$ | Input voltage | -0.3 to 3.6 | V |
| $\mathrm{~V}_{\mathrm{O}}$ | Output voltage (OFF state) | 0 to 3.6 | V |
| $\mathrm{~V}_{\mathrm{O}}$ | Output voltage (high or low state) | 0 to $\mathrm{V}_{\mathrm{CC}}$ | V |
| $\mathrm{I}_{\mathrm{OH},} \mathrm{I}_{\mathrm{OL}}$ | High or low level output current $\left(\mathrm{V}_{\mathrm{CC}}=3.0\right.$ to 3.6 V$)$ | $\pm 12$ | mA |
| $\mathrm{I}_{\mathrm{OH}}, \mathrm{I}_{\mathrm{OL}}$ | High or low level output current $\left(\mathrm{V}_{\mathrm{CC}}=2.3\right.$ to 2.7 V$)$ | $\pm 8$ | mA |
| $\mathrm{~T}_{\mathrm{Op}}$ | Operating temperature | -55 to 125 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{dt} / \mathrm{dv}$ | Input rise and fall time ${ }^{(1)}$ | 0 to 10 | $\mathrm{~ns} / \mathrm{V}$ |

1. $\mathrm{V}_{\text {IN }}$ from 0.8 V to 2 V at $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}$

## 4 Electrical characteristics

2.7 $\mathrm{V}<\mathrm{V}_{\mathrm{CC}}<3.6 \mathrm{~V}$ unless otherwise specified

Table 5. DC specifications

| Symbol | Parameter | Test condition |  | Value <br> -55 to $125^{\circ} \mathrm{C}$ |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $V_{c c}$ <br> (V) |  |  |  |  |
|  |  |  |  | Min. | Max. |  |
| $\mathrm{V}_{\mathrm{IH}}$ | High level input voltage | 2.7 to 3.6 |  | 2.0 |  | V |
| $\mathrm{V}_{\text {IL }}$ | Low level input voltage |  |  |  | 0.8 |  |
| $\mathrm{V}_{\mathrm{OH}}$ | High level output voltage | 2.7 to 3.6 | $\mathrm{I}_{\mathrm{O}}=-100 \mu \mathrm{~A}$ | $\mathrm{V}_{\mathrm{CC}}-0.2$ |  | V |
|  |  | 2.7 | $\mathrm{I}_{\mathrm{O}}=-6 \mathrm{~mA}$ | 2.2 |  |  |
|  |  | 3.0 | $\mathrm{I}_{\mathrm{O}}=-8 \mathrm{~mA}$ | 2.4 |  |  |
|  |  |  | $\mathrm{I}_{\mathrm{O}}=-12 \mathrm{~mA}$ | 2.2 |  |  |
| $\mathrm{V}_{\mathrm{OL}}$ | Low level output voltage | 2.7 to 3.6 | $\mathrm{I}_{\mathrm{O}}=100 \mu \mathrm{~A}$ |  | 0.2 | V |
|  |  | 2.7 | $\mathrm{I}_{\mathrm{O}}=6 \mathrm{~mA}$ |  | 0.4 |  |
|  |  | 3.0 | $\mathrm{l}_{\mathrm{O}}=8 \mathrm{~mA}$ |  | 0.5 |  |
|  |  |  | $\mathrm{I}_{\mathrm{O}}=12 \mathrm{~mA}$ |  | 0.8 |  |
| 1 | Input leakage current | 2.7 to 3.6 | $\mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{CC}}$ or GND |  | $\pm 5$ | $\mu \mathrm{A}$ |
| $I_{\text {(HOLD })}$ | Input hold current | 3.0 | $\mathrm{V}_{1}=0.8 \mathrm{~V}$ | 75 |  | $\mu \mathrm{A}$ |
|  |  |  | $\mathrm{V}_{1}=2 \mathrm{~V}$ | -75 |  |  |
|  |  | 3.6 | $\mathrm{V}_{1}=0$ to 3.6 V |  | $\pm 500$ |  |
| $\mathrm{I}_{\text {off }}$ | Power off leakage current | 0 | $\mathrm{V}_{1}$ or $\mathrm{V}_{\mathrm{O}}=0$ to 3.6 V |  | 10 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {Oz }}$ | High impedance output leakage current | 2.7 to 3.6 | $\begin{aligned} & V_{1}=V_{1 H} \text { or } V_{1 L} \\ & V_{O}=0 \text { to } 3.6 \mathrm{~V} \end{aligned}$ |  | $\pm 10$ | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\mathrm{CC}}$ | Quiescent supply current | 2.7 to 3.6 | $\mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{CC}}$ or GND |  | 20 | $\mu \mathrm{A}$ |
|  |  |  | $\begin{gathered} \mathrm{V}_{1} \text { or } \mathrm{V}_{\mathrm{O}}= \\ \mathrm{V}_{\mathrm{CC}} \text { to } 3.6 \mathrm{~V} \end{gathered}$ |  | $\pm 20$ |  |
| $\Delta \mathrm{l}_{\text {CC }}$ | ${ }^{\text {cc }}$ incr. per input | 2.7 to 3.6 | $\mathrm{V}_{\mathrm{IH}}=\mathrm{V}_{\mathrm{CC}}-0.6 \mathrm{~V}$ |  | 750 | $\mu \mathrm{A}$ |

$2.3 \mathrm{~V}<\mathrm{V}_{\mathrm{CC}}<2.7 \mathrm{~V}$ unless otherwise specified
Table 6. DC specifications

| Symbol | Parameter | Test condition |  | Value$-55 \text { to } 125{ }^{\circ} \mathrm{C}$ |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\mathrm{V}_{\mathrm{cc}}$ <br> (V) |  |  |  |  |
|  |  |  |  | Min. | Max. |  |
| $\mathrm{V}_{\mathrm{IH}}$ | High level input voltage | 2.3 to 2.7 |  | 1.6 |  | V |
| $\mathrm{V}_{\text {IL }}$ | Low level input voltage |  |  |  | 0.7 |  |
| $\mathrm{V}_{\mathrm{OH}}$ | High level output voltage | 2.3 to 2.7 | $\mathrm{I}_{\mathrm{O}}=-100 \mu \mathrm{~A}$ | $\mathrm{V}_{\mathrm{CC}}-0.2$ |  | V |
|  |  | 2.3 | $\mathrm{I}_{\mathrm{O}}=-4 \mathrm{~mA}$ | 2.0 |  |  |
|  |  |  | $\mathrm{I}_{\mathrm{O}}=-6 \mathrm{~mA}$ | 1.8 |  |  |
|  |  |  | $\mathrm{I}_{\mathrm{O}}=-8 \mathrm{~mA}$ | 1.7 |  |  |
| $\mathrm{V}_{\mathrm{OL}}$ | Low level output voltage | 2.3 to 2.7 | $\mathrm{I}_{\mathrm{O}}=100 \mu \mathrm{~A}$ |  | 0.2 | V |
|  |  | 2.3 | $\mathrm{I}_{\mathrm{O}}=6 \mathrm{~mA}$ |  | 0.4 |  |
|  |  |  | $\mathrm{I}_{\mathrm{O}}=8 \mathrm{~mA}$ |  | 0.6 |  |
| 1 | Input leakage current | 2.3 to 2.7 | $\mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{CC}}$ or GND |  | $\pm 5$ | $\mu \mathrm{A}$ |
| $I_{\text {(HOLD) }}$ | Input hold current | 2.3 | $\mathrm{V}_{1}=0.7 \mathrm{~V}$ | 45 |  | $\mu \mathrm{A}$ |
|  |  |  | $\mathrm{V}_{1}=1.7 \mathrm{~V}$ | -45 |  |  |
| $\mathrm{l}_{\text {off }}$ | Power off leakage current | 0 | $\mathrm{V}_{1}$ or $\mathrm{V}_{\mathrm{O}}=0$ to 3.6 V |  | 10 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {Oz }}$ | High impedance output leakage current | 2.3 to 2.7 | $\begin{aligned} & V_{I}=V_{I H} \text { or } V_{I L} \\ & V_{O}=0 \text { to } 3.6 \mathrm{~V} \end{aligned}$ |  | $\pm 10$ | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\mathrm{CC}}$ | Quiescent supply current | 2.3 to 2.7 | $\mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{CC}}$ or GND |  | 20 | $\mu \mathrm{A}$ |
|  |  |  | $\begin{gathered} \mathrm{V}_{1} \text { or } \mathrm{V}_{\mathrm{O}}= \\ \mathrm{V}_{\mathrm{CC}} \text { to } 3.6 \mathrm{~V} \end{gathered}$ |  | $\pm 20$ |  |

$T_{A}=25^{\circ} \mathrm{C}$, Input $\mathrm{t}_{\mathrm{r}}=\mathrm{t}_{\mathrm{f}}=2.0 \mathrm{~ns}, \mathrm{C}_{\mathrm{L}}=30 \mathrm{pF}, \mathrm{R}_{\mathrm{L}}=500 \Omega$
Table 7. Dynamic switching characteristics

| Symbol | Parameter | Test condition |  | Value | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\mathrm{v}_{\mathrm{cc}}$ (V) |  | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  |
| $\mathrm{V}_{\text {OLP }}$ | Dynamic low voltage quiet output ${ }^{(1)}$ (2) | 2.5 | $\begin{gathered} \mathrm{V}_{\mathrm{IL}}=0 \mathrm{~V} \\ \mathrm{~V}_{\mathrm{IH}}=\mathrm{V}_{\mathrm{CC}} \end{gathered}$ | 0.25 | V |
|  |  | 3.3 |  | 0.35 |  |
| $\mathrm{V}_{\text {OLV }}$ | Dynamic low voltage quiet output ${ }^{(1)}{ }^{(2)}$ | 2.5 | $\begin{gathered} \mathrm{V}_{\mathrm{IL}}=0 \mathrm{~V} \\ \mathrm{~V}_{\mathrm{IH}}=\mathrm{V}_{\mathrm{CC}} \end{gathered}$ | -0.25 | V |
|  |  | 3.3 |  | -0.35 |  |
| $\mathrm{V}_{\mathrm{OHV}}$ | Dynamic high voltage quiet output <br> (2) (3) | 2.5 | $\begin{gathered} \mathrm{V}_{\mathrm{IL}}=0 \mathrm{~V} \\ \mathrm{~V}_{\mathrm{IH}}=\mathrm{V}_{\mathrm{CC}} \end{gathered}$ | 2.05 | V |
|  |  | 3.3 |  | 2.65 |  |

1. Number of outputs defined as " $n$ ". Measured with " $n-1$ " outputs switching from HIGH to LOW or LOW to HIGH. The remaining output is measured in the LOW state.
2. Parameters guaranteed by design.
3. Number of outputs defined as " $n$ ". Measured with " $n-1$ " outputs switching from HIGH to LOW or LOW to HIGH. The remaining output is measured in the HIGH state.
$C_{L}=30 \mathrm{pF}, \mathrm{R}_{\mathrm{L}}=500 \Omega$, Input $\mathrm{t}_{\mathrm{r}}=\mathrm{t}_{\mathrm{f}}=2.0 \mathrm{~ns}$
Table 8. AC electrical characteristics

| Symbol | Parameter | Test condition |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\mathrm{V}_{\mathrm{cc}}$ <br> (V) | -55 to $125{ }^{\circ} \mathrm{C}$ |  |  |
|  |  |  | Min. | Max. |  |
| $t_{\text {PLH }} \mathrm{t}_{\text {PHL }}$ | Propagation delay time | 2.3 to 2.7 | 1.0 | 5.2 | ns |
|  |  | 3.0 to 3.6 | 0.8 | 5.0 |  |
| $t_{\text {PzL }} \mathrm{t}_{\text {PZH }}$ | Output enable time | 2.3 to 2.7 | 1.0 | 5.8 | ns |
|  |  | 3.0 to 3.6 | 0.8 | 4.2 |  |
| $\mathrm{t}_{\mathrm{PLZ}} \mathrm{t}_{\text {PHZ }}$ | Output disable time | 2.3 to 2.7 | 1.0 | 4.5 | ns |
|  |  | 3.0 to 3.6 | 0.8 | 4.0 |  |
| $\mathrm{t}_{\text {OSLH }}{ }^{\text {toshL }}$ | Output to output skew time ${ }^{(1)(2)}$ | 2.3 to 2.7 |  | 0.5 | ns |
|  |  | 3.0 to 3.6 |  | 0.5 |  |

1. Skew is defined as the absolute value of the difference between the actual propagation delay for any two outputs of the same device switching in the same direction, either HIGH or LOW ( $\mathrm{t}_{\mathrm{OSLH}}=\left|\mathrm{t}_{\text {PLHm }}-\mathrm{t}_{\text {PLHn }}\right|$, $\left.\mathrm{t}_{\mathrm{OSHL}}=\left|\mathrm{t}_{\text {PHLm }}-\mathrm{t}_{\text {PHLn }}\right|\right)$
2. Parameter guaranteed by design

Table 9. Capacitive characteristics

| Symbol | Parameter | Test condition |  | Value | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\mathrm{V}_{\mathrm{cc}}$ (V) |  | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  |
| $\mathrm{C}_{\text {IN }}$ | Input capacitance | 2.5 or 3.3 | $\mathrm{V}_{\text {IN }}=0$ or $\mathrm{V}_{\text {CC }}$ | 6 | pF |
| COUT | Output capacitance | 2.5 or 3.3 | $\mathrm{V}_{\mathrm{IN}}=0$ or $\mathrm{V}_{\mathrm{CC}}$ | 7 | pF |
| $\mathrm{C}_{\text {PD }}$ | Power dissipation capacitance ${ }^{(1)}$ | 2.5 or 3.3 | $\begin{aligned} \mathrm{f}_{\mathrm{IN}} & =10 \mathrm{MHz} \\ \mathrm{~V}_{\mathrm{IN}} & =0 \text { or } \mathrm{V}_{\mathrm{CC}} \end{aligned}$ | 20 | pF |

1. $C_{P D}$ is defined as the value of the IC's internal equivalent capacitance which is calculated from the operating current consumption without load. (Refer to test circuit). Average operating current can be obtained by the following equation. $\mathrm{I}_{\mathrm{CC}(\mathrm{opr})}=\mathrm{C}_{\mathrm{PD}} \times \mathrm{V}_{\mathrm{CC}} \times \mathrm{f}_{\mathrm{IN}}+\mathrm{I}_{\mathrm{CC}} / 16$ (per circuit)

## 5 Test circuit

Figure 4. Application circuit


Table 10. Test circuit

| Test | Switch |
| :--- | :---: |
| $\mathrm{t}_{\text {PLH }}, \mathrm{t}_{\text {PHL }}$ | Open |
| $\mathrm{t}_{\text {PZL }}, \mathrm{t}_{\text {PLZ }}\left(\mathrm{V}_{\mathrm{CC}}=3.0\right.$ to 3.6 V$)$ | 6 V |
| $\mathrm{t}_{\text {PZL }}, \mathrm{t}_{\mathrm{PLZ}}\left(\mathrm{V}_{\mathrm{CC}}=2.3\right.$ to 2.7 V$)$ | $2 \mathrm{~V}_{\mathrm{CC}}$ |
| $\mathrm{t}_{\text {PZH }}, \mathrm{t}_{\text {PHZ }}$ | GND |

$C_{L}=10 / 30 \mathrm{pF}$ or equivalent (includes jig and probe capacitance)
$R_{L}=R_{1}=500 \Omega$ or equivalent
$R_{T}=Z_{\text {OUT }}$ of pulse generator (typically $50 \Omega$ )

## 6 Waveforms

Table 11. Waveform symbol value

| Symbol | $\mathrm{V}_{\mathrm{Cc}}$ |  |
| :---: | :---: | :---: |
|  | $\mathbf{3 . 0}$ to 3.6 V | $\mathbf{2 . 3}$ to 2.7 V |
| $\mathrm{~V}_{\mathrm{IH}}$ | 2.7 V | $\mathrm{~V}_{\mathrm{CC}}$ |
| $\mathrm{V}_{\mathrm{M}}$ | 1.5 V | $\mathrm{~V}_{\mathrm{CC}} / 2$ |
| $\mathrm{~V}_{\mathrm{X}}$ | $\mathrm{V}_{\mathrm{OL}}+0.3 \mathrm{~V}$ | $\mathrm{~V}_{\mathrm{OL}}+0.15 \mathrm{~V}$ |
| $\mathrm{~V}_{\mathrm{Y}}$ | $\mathrm{V}_{\mathrm{OH}}-0.3 \mathrm{~V}$ | $\mathrm{~V}_{\mathrm{OH}}-0.15 \mathrm{~V}$ |

Figure 5. Waveform - propagation delay ( $f=1 \mathbf{M H z} ; \mathbf{5 0 \%}$ duty cycle)


Figure 6. Waveform - output enable and disable time ( $\mathrm{f}=1 \mathrm{MHz}$; 50\% duty cycle)


## $7 \quad$ Package mechanical data

54VCXH162245 products are supplied into ceramic body / metal lid hermetic Flat 48-pin space package
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK ${ }^{\circledR}$ packages, depending on their level of environmental compliance. ECOPACK ${ }^{\circledR}$ specifications, grade definitions and product status are available at: www.st.com. ECOPACK ${ }^{\circledR}$ is an ST trademark.

Table 12. Flat-48 (MIL-STD-1835) mechanical data

| Dim. | mm |  |  | inch |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | Min. | Typ. | Max. | Min. | Typ. | Max. |
| A | 2.18 | 2.47 | 2.72 | 0.086 | 0.097 | 0.107 |
| b | 0.20 | 0.254 | 0.30 | 0.008 | 0.010 | 0.012 |
| c | 0.12 | 0.15 | 0.18 | 0.005 | 0.006 | 0.007 |
| D | 15.57 | 15.75 | 15.92 | 0.613 | 0.620 | 0.627 |
| E | 9.52 | 9.65 | 9.78 | 0.375 | 0.380 | 0.385 |
| E2 | 6.22 | 6.35 | 6.48 | 0.245 | 0.250 | 0.255 |
| E3 | 1.52 | 1.65 | 1.78 | 0.060 | 0.065 | 0.070 |
| e |  | 0.635 |  |  | 0.025 |  |
| f |  | 0.20 |  |  | 0.008 |  |
| L | 6.85 | 8.38 | 9.40 | 0.270 | 0.330 | 0.370 |
| Q | 0.66 | 0.79 | 0.92 | 0.026 | 0.031 | 0.036 |
| S1 | 0.25 | 0.43 | 0.61 | 0.010 | 0.017 | 0.024 |

Figure 7. Package dimension


Note: $\quad$ The upper metallic lid is not electrically connected to any pins, nor to the IC die inside the package. Connecting unused pins or metal lid to ground or to the power supply will not affect the electrical characteristics.

## 8 Order codes

Table 13. Ordering information

| Package | Min op. <br> voltage | Lead <br> finish | Radiation <br> level | Flight models | Engineering <br> model | Packing |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| QML-V |  |  |  |  |  |  |
| 48-pin flat | 1.8 V | gold plated | 300 krad | RHFXH162244K03V | RHRXH162244K1 | Conductive strip pack |
| Die | 3.6 V to 1.8 V | - | 100 krad | RXH162244DIE2V |  |  |

## $9 \quad$ Revision history

Table 14. Document revision history

| Date | Revision | Changes |
| :---: | :---: | :--- |
| 09-Jul-2004 | 1 | First release |
| 17-May-2005 | 2 | SMD qualified |
| 19-Jun-2006 | 3 | 300 krad bullet updated, new template, mechanical data updated |
| 11-Apr-2007 | 4 | Updated cover page features |
| 30-Jul-2007 | 5 | Typo in Table 12 on page 14 |
| 17-Sep-2008 | 6 | Updated cover page |
| 09-Jan-2009 | 7 | Updated cover page |
| 23-Sep-2009 | 8 | Updated Table 13 on page 16 |
| 29-Jul-2011 | 9 | Added Note: on page 15 and in the "Pin connections" diagram on the <br> coverpage |

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